







SN54HC688, SN74HC688 SCLS010F – DECEMBER 1982 – REVISED MAY 2022

## SN54HC688, SN74HC688 8-Bit Identity Comparators

### **1** Features

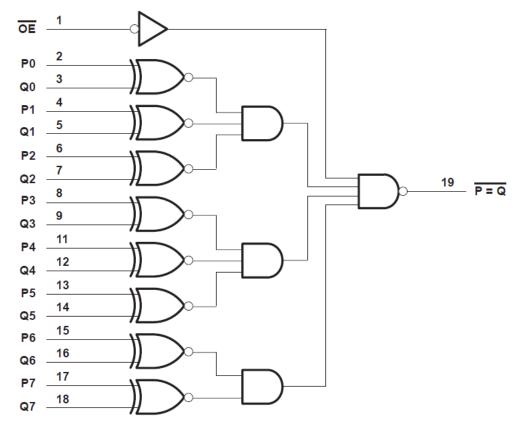
- Wide operating voltage range of 2 V to 6 V
- High-current outputs drive up to 10 LSTTL loads
- Low power consumption, 80-µA max I<sub>CC</sub>
- Typical t<sub>pd</sub> = 14 ns
- ±4-mA output drive at 5 V
- Low input current of 1 µA max
- Compare two 8-bit words

### **2 Description**

These identity comparators perform comparisons of two 8-bit binary or BCD words. An output-enable ( $\overline{OE}$ ) input may be used to force the output to the high level.

Device Information							
PART NUMBER	BODY SIZE (NOM)						
SN74HC688DW	SOIC (20)	12.80 mm × 7.50 mm					
SN74HC688N	PDIP (20)	25.40 mm × 6.35 mm					
SN74HC688PWR	TSSOP (20)	6.50 mm × 4.40 mm					
SN54HC688J	CDIP (20)	26.92 mm × 6.92 mm					
SNJ54HC688FK	LCCC (20)	8.89 mm × 8.45 mm					

 For all available packages, see the orderable addendum at the end of the data sheet.



**Functional Block Diagram** 



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### **3 Revision History**

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

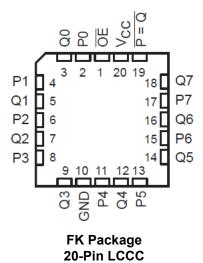
С	Changes from Revision E (February 2022) to Revision F (May 2022)	Page
•	Junction-to-ambient thermal resistance values increased. DW was 58 is now 109.1, N was 69 is PW was 83 is now 131.8	,
С	Changes from Revision D (August 2003) to Revision E (February 2022)	Page
•	Updated the numbering, formatting, tables, figures, and cross-references throughout the docume	ent to reflect



### **4** Pin Configuration and Functions

			L
1	$\cup$	20	V <sub>CC</sub>
2		19	<u>P = Q</u>
3		18	Q7
4		17	P7
5		16	Q6
6		15	P6
7		14	Q5
8		13	P5
9		12	Q4
10		11	P4
	4 5 7 8 9	2 3 5 6 7 8 9	2 19 3 18 4 17 5 16 6 15 7 14 8 13 9 12

J, DW, N or PW package 20-Pin CDIP, SOIC, PDIP, TSSOP Top View



Top View



### **5** Specifications

### 5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range		-0.5	7	V
I <sub>IK</sub>	Input clamp current <sup>(2)</sup>	$V_{I} < 0 \text{ or } V_{I} > V_{CC}$		±20	mA
I <sub>ок</sub>	Output clamp current <sup>(2)</sup>	$V_{O}$ < 0 or $V_{O}$ > $V_{CC}$		±20	mA
I <sub>O</sub>	Continuous output current	$V_{O} = 0$ to $V_{CC}$		±25	mA
	Continuous current through $V_{CC}$ or GND			±50	mA
TJ	Junction temperature			150	°C
T <sub>stg</sub>	Storage temperature range		65	150	C°

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

### 5.2 Recommended Operating Conditions<sup>(1)</sup>

			SN54HC688		SN74HC688			UNIT	
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
V <sub>CC</sub>	Supply voltage		2	5	6	2	5	6	V
		V <sub>CC</sub> = 2 V	1.5			1.5			
VIH	High-level input voltage	V <sub>CC</sub> = 4.5 V	3.15			3.15			V
		V <sub>CC</sub> = 6 V	4.2			4.2			
		V <sub>CC</sub> = 2 V 0.5			0.5				
VIL	/ <sub>IL</sub> Low-level input voltage	V <sub>CC</sub> = 4.5 V			1.35			1.35	V
		V <sub>CC</sub> = 6 V			1.8			1.8	
VI	Input voltage		0		V <sub>CC</sub>	0		$V_{CC}$	V
Vo	Output voltage		0		V <sub>CC</sub>	0		V <sub>CC</sub>	V
		V <sub>CC</sub> = 2 V			1000			1000	
tt	Input transition (rise and fall) time	V <sub>CC</sub> = 4.5 V			500			500	ns
		V <sub>CC</sub> = 6 V			400			400	
T <sub>A</sub>	Operating free-air temperature		-55		125	-40		85	°C

 All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

#### **5.3 Thermal Information**

		DW (SOIC)	N (PDIP)	PW (TSSOP)	
THERMAL METRIC		20 PINS	20 PINS	20 PINS	UNIT
R <sub>θJA</sub>	Junction-to-ambient thermal resistance <sup>(1)</sup>	109.1	84.6	131.8	°C/W
R <sub>0JC(top)</sub>	Junction-to-case (top) thermal resistance	76	72.5	72.2	°C/W
R <sub>θJB</sub>	Junction-to-board thermal resistance	77.6	65.3	82.8	°C/W
Ψ <sub>JT</sub>	Junction-to-top characterization parameter	51.5	55.3	21.5	°C/W
Ψјв	Junction-to-board characterization parameter	77.1	65.2	82.4	°C/W
R <sub>0JC(bot)</sub>	Junction-to-case (bottom) thermal resistance	N/A	N/A	N/A	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC package thermal metrics application report.



### **5.4 Electrical Characteristics**

PARAMETER	TEST CO	TEST CONDITIONS		T,	<sub>A</sub> = 25°C		SN54HC	688	SN74H	C688	UNIT
FARAMETER	1231 00	NDITIONS	V <sub>cc</sub>	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
			2 V	1.9	1.998		1.9		1.9		
		I <sub>OH</sub> = –20 μA	4.5 V	4.4	4.499		4.4		4.4		
V <sub>OH</sub>	$V_{I} = V_{IH} \text{ or } V_{IL}$		6 V	5.9	5.999		5.9		5.9		V
		I <sub>OH</sub> =4 mA	4.5 V	3.98	4.3		3.7		3.84		
		I <sub>OH</sub> = -5.2 mA	6 V	5.48	5.8		5.2		5.34		
			2 V		0.002	0.1		0.1		0.1	
		I <sub>OL</sub> = 20 μA	4.5 V		0.001	0.1		0.1		0.1	
V <sub>OL</sub>	$V_{I} = V_{IH} \text{ or } V_{IL}$		6 V		0.001	0.1		0.1		0.1	V
		I <sub>OL</sub> = 4 mA	4.5 V		0.17	0.26		0.4		0.33	
		I <sub>OL</sub> = 5.2 mA	6 V		0.15	0.26		0.4	·	0.33	
I <sub>I</sub>	$V_{I} = V_{CC} \text{ or } 0$	•	6 V		±0.1	±100		±1000		±1000	nA
I <sub>CC</sub>	$V_{I} = V_{CC} \text{ or } 0,$	I <sub>O</sub> = 0	6 V			8		160		80	μA
Ci			2 V to 6 V		3	10		10		10	pF

over recommended operating free-air temperature range (unless otherwise noted)

### 5.5 Switching Characteristics

over recommended operating free-air temperature range,  $C_L = 50 \text{ pF}$  (unless otherwise noted) (see Parameter Measurement Information)

PARAMETER	FROM	то	V	TA	= 25°C		SN54HC6	88	SN74HC	688	UNIT
PARAIVIETER	(INPUT)	(OUTPUT)	V <sub>cc</sub>	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
			2 V		113	210		313		265	
	P or Q	$\overline{P} = Q$	4.5 V		30	42		63		53	
+ .			6 V		24	36		53		45	ns
t <sub>pd</sub>			2 V		66	120		179		151	115
	ŌĒ	P = Q	4.5 V		16	24		36		30	
			6 V		14	20		30		26	
			2 V		38	75		110		95	
tt		Any	4.5 V		8	15		22		19	ns
			6 V		6	13		19		16	

#### **5.6 Operating Characteristics**

T<sub>A</sub> = 25°C

	PARAMETER		ТҮР	UNIT	
C <sub>pd</sub>	Power dissipation capacitance	No load	40	pF	



 $V_{CC}$ 

0 V

V<sub>CC</sub>

VOL

 $V_{OH}$ 

≈ 0 V

- t<sub>PLZ</sub><sup>(4)</sup>

10%

t<sub>PHZ</sub><sup>(4)</sup>

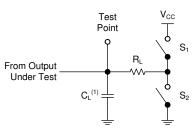
90%

### **6** Parameter Measurement Information

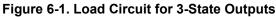
Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>t</sub> < 6 ns.

For clock inputs, f<sub>max</sub> is measured when the input duty cycle is 50%.

The outputs are measured one at a time with one input transition per measurement.



(1) C<sub>L</sub> includes probe and test-fixture capacitance.



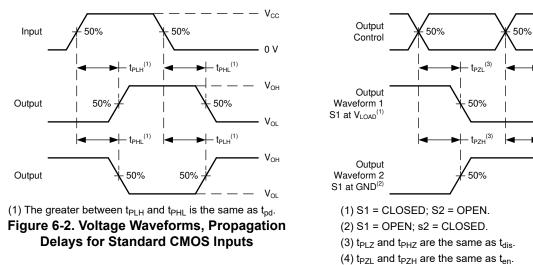
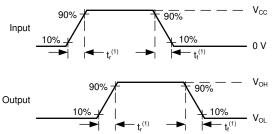


Figure 6-3. Voltage Waveforms, Standard CMOS Inputs Propagation Delays



(1) The greater between  $t_r$  and  $t_f$  is the same as  $t_t$ .

Figure 6-4. Voltage Waveforms, Input and Output Transition Times for Standard CMOS Inputs

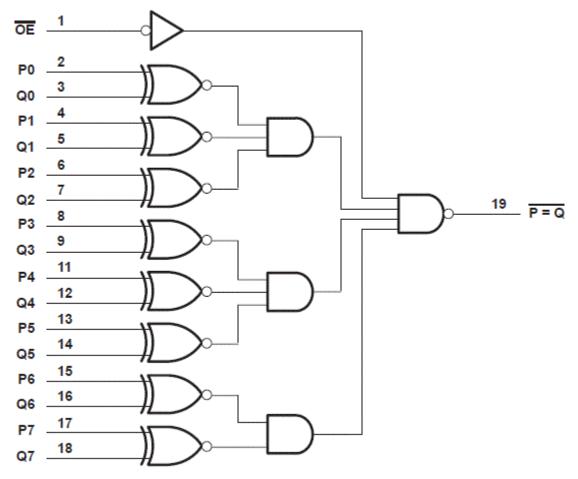


### 7 Detailed Description

### 7.1 Overview

These identity comparators perform comparisons of two 8-bit binary or BCD words. An output-enable ( $\overline{OE}$ ) input may be used to force the output to the high level.

### 7.2 Functional Block Diagram



#### 7.3 Device Functional Modes

INP	Table 7-1. Function Ta					
DATA P, Q	ŌĒ	$OUTPUT$ $\overline{P = Q}$				
P = Q	L	L				
P > Q	Х	Н				
P < Q	Х	Н				
Х	Н	Н				

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### 8 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*. Each  $V_{CC}$  terminal should have a good bypass capacitor to prevent power disturbance. A 0.1- $\mu$ F capacitor is recommended for this device. It is acceptable to parallel multiple bypass caps to reject different frequencies of noise. The 0.1- $\mu$ F and 1- $\mu$ F capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results.

### 9 Layout

#### 9.1 Layout Guidelines

When using multiple-input and multiple-channel logic devices inputs must not ever be left floating. In many cases, functions or parts of functions of digital logic devices are unused; for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such unused input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. All unused inputs of digital logic devices must be connected to a logic high or logic low voltage, as defined by the input voltage specifications, to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally, the inputs are tied to GND or  $V_{CC}$ , whichever makes more sense for the logic function or is more convenient.



### **10 Device and Documentation Support**

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

#### **10.1 Receiving Notification of Documentation Updates**

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### **10.2 Support Resources**

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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#### 10.3 Trademarks

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#### **10.4 Electrostatic Discharge Caution**



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 10.5 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

### 11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



### **PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
5962-86818012A	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 86818012A SNJ54HC 688FK	Samples
5962-8681801RA	ACTIVE	CDIP	J	20	20	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8681801RA SNJ54HC688J	Samples
SN54HC688J	ACTIVE	CDIP	J	20	20	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	SN54HC688J	Samples
SN74HC688DW	OBSOLETE	SOIC	DW	20		TBD	Call TI	Call TI	-40 to 85	HC688	
SN74HC688DWR	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC688	Samples
SN74HC688DWRE4	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC688	Samples
SN74HC688DWRG4	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC688	Samples
SN74HC688N	ACTIVE	PDIP	Ν	20	20	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 85	SN74HC688N	Samples
SN74HC688PWR	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC688	Samples
SN74HC688PWRE4	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC688	Samples
SN74HC688PWT	OBSOLETE	TSSOP	PW	20		TBD	Call TI	Call TI	-40 to 85	HC688	
SNJ54HC688FK	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 86818012A SNJ54HC 688FK	Samples
SNJ54HC688J	ACTIVE	CDIP	J	20	20	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8681801RA SNJ54HC688J	Samples

<sup>(1)</sup> The marketing status values are defined as follows: **ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design. **PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.



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<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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#### OTHER QUALIFIED VERSIONS OF SN54HC688, SN74HC688 :

• Catalog : SN74HC688

Military : SN54HC688

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications



Texas

STRUMENTS

### TAPE AND REEL INFORMATION





#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74HC688DWR	SOIC	DW	20	2000	330.0	24.4	10.9	13.3	2.7	12.0	24.0	Q1
SN74HC688PWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1
SN74HC688PWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1



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# PACKAGE MATERIALS INFORMATION

9-Feb-2024



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74HC688DWR	SOIC	DW	20	2000	367.0	367.0	45.0
SN74HC688PWR	TSSOP	PW	20	2000	356.0	356.0	35.0
SN74HC688PWR	TSSOP	PW	20	2000	356.0	356.0	35.0

### TEXAS INSTRUMENTS

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### TUBE



### - B - Alignment groove width

#### \*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	Τ (μm)	B (mm)
5962-86818012A	FK	LCCC	20	55	506.98	12.06	2030	NA
SN74HC688N	N	PDIP	20	20	506	13.97	11230	4.32
SNJ54HC688FK	FK	LCCC	20	55	506.98	12.06	2030	NA

J (R-GDIP-T\*\*) 14 LEADS SHOWN

CERAMIC DUAL IN-LINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

# FK 20

### 8.89 x 8.89, 1.27 mm pitch

# **GENERIC PACKAGE VIEW**

## LCCC - 2.03 mm max height

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





# N (R-PDIP-T\*\*)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- $\triangle$  The 20 pin end lead shoulder width is a vendor option, either half or full width.



# **DW0020A**



# **PACKAGE OUTLINE**

### SOIC - 2.65 mm max height

SOIC



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



# DW0020A

# **EXAMPLE BOARD LAYOUT**

## SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



# DW0020A

# **EXAMPLE STENCIL DESIGN**

## SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



# **PW0020A**



# **PACKAGE OUTLINE**

## TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



# PW0020A

# **EXAMPLE BOARD LAYOUT**

## TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



# PW0020A

# **EXAMPLE STENCIL DESIGN**

## TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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